Innovating Energy Technology

FMW35N60S1HF

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FUJI POWER MOSFET

Super J-MOS series

N-Channel enhancement mode power MOSFET

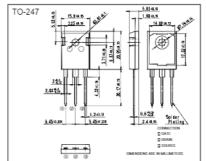
Features

Pb-free lead terminal RoHS compliant uses Halogen-free molding compound

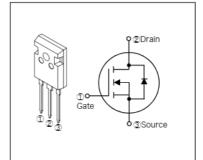
Applications

For switching

Outline Drawings [mm]



Equivalent circuit schematic



■ Absolute Maximum Ratings at T_c=25°C (unless otherwise specified)

Parameter	Symbol	Characteristics	Unit	Remarks
Drain-Source Voltage	V _{DS}	600	V	
	V _{DSX}	600	V	V _{ss} =-30V
Condinuous Brain Comment	l _o	±35	А	Tc=25°C Note*1
Continuous Drain Current		±22	А	Tc=100°C Note*1
Pulsed Drain Current	IDP	±105	А	Note *1
Gate-Source Voltage	V _G s	±30	V	
Repetitive and Non-Repetitive Maximum Avalanche Current	lar	6.6	А	Note *2
Non-Repetitive Maximum Avalanche Energy	Eas	1239.6	mJ	Note *3
Maximum Drain-Source dV/dt	dV₂s/dt	50	kV/μs	Vos≤ 600V
Peak Diode Recovery dV/dt	dV/dt	15	kV/μs	Note *4
Peak Diode Recovery -di/dt	-di/dt	100	A/µs	Note *5
	Б	2.5	10/	T _a =25°C
Maximum Power Dissipation	P₀	270	W	Tc=25°C
Operating and Storage Temperature range	T _{ch}	150	°C	
	T _{stg}	-55 to +150	°C	

Note *1 : Limited by maximum channel temperature. Note *2 : $Tot=150^{\circ}C$, See Fig.1 and Fig.2 Note *3 : Starting $Tot=25^{\circ}C$, Ias=4A, L=142mH, Vob=60V, $Ro=50\Omega$, See Fig.1 and Fig.2

EAS limited by maximum channel temperature and avalanche current.

Note *4: Ir≤-lp, -di/dt=100A/µs, Vps peak≤600V, Toh≤150°C.

Note *5: Ir≤-lp, dV/dt=15kV/µs, Vps peak≤600V, Toh≤150°C.

■ Electrical Characteristics at T_c=25°C (unless otherwise specified)

Static Ratings

Parameter	Symbol	Conditions		min.	typ.	max.	Unit
Drain-Source Breakdown Voltage	BVoss	I _D =250μA V _{GS} =0V		600	-	-	V
Gate Threshold Voltage	V _{GS(th)}	I _D =250µA V _{DS} =V _{GS}		2.5	3.0	3.5	V
Zero Gate Voltage Drain Current	loss	V _{DS} =600V V _{GS} =0V	T _{ch} =25°C	-	-	25	- μΑ
		V _{DS} =480V V _{GS} =0V	T _{ch} =125°C	-	-	250	
Gate-Source Leakage Current	Igss	V _{ss} = ± 30V V _{ps} =0V		-	10	100	nA
Drain-Source On-State Resistance	Ros(on)	I _D =17.5A V _{GS} =10V		-	0.084	0.099	Ω
Gate resistance	Rs	f=1MHz, open drain		-	1.1	-	Ω

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• Dynamic Ratings

Parameter	Symbol	Conditions	min.	typ.	max.	Unit
Forward Transconductance	grs .	I _D =17.5A V _{DS} =25V	14.5	29	-	S
Input Capacitance	Clas	V _{ps} =10V	-	2850	-	
Output Capacitance	Coss	V _{GS} =0V	-	5960	-	
Reverse Transfer Capacitance	Crss	f=1MHz	-	550	-	
Effective output capacitance, energy related (Note *6)	C _{o(er)}	V _{ss} =0V V _{ps} =0480V	-	160	-	pF
Effective output capacitance, time related (Note *7)	C _{o(tr)}	V _{ss} =0V V _{ps} =0480V ID=constant	-	560	-	
Turn-On Time	t _{d(on)}		-	92	-	
iurn-On Time	tr	V _{DD} =400V, V _{GS} =10V	-	23	-	
Turn-Off Time	t _{d(off)}	I₀=17.5A, R₀=18Ω See Fig.3 and Fig.4	-	182	-	ns ns
Turn-Off Time	tr		-	18	-	
Total Gate Charge	Q _G		-	87	-	
Gate-Source Charge	Qgs	V _{DD} =480V, I _D =35A V _{DS} =10V See Fig.5	-	21	-	nC
Gate-Drain Charge	Q _{GD}		-	33	-	nC nC
Drain-Source crossover Charge	Qsw		-	12	-	

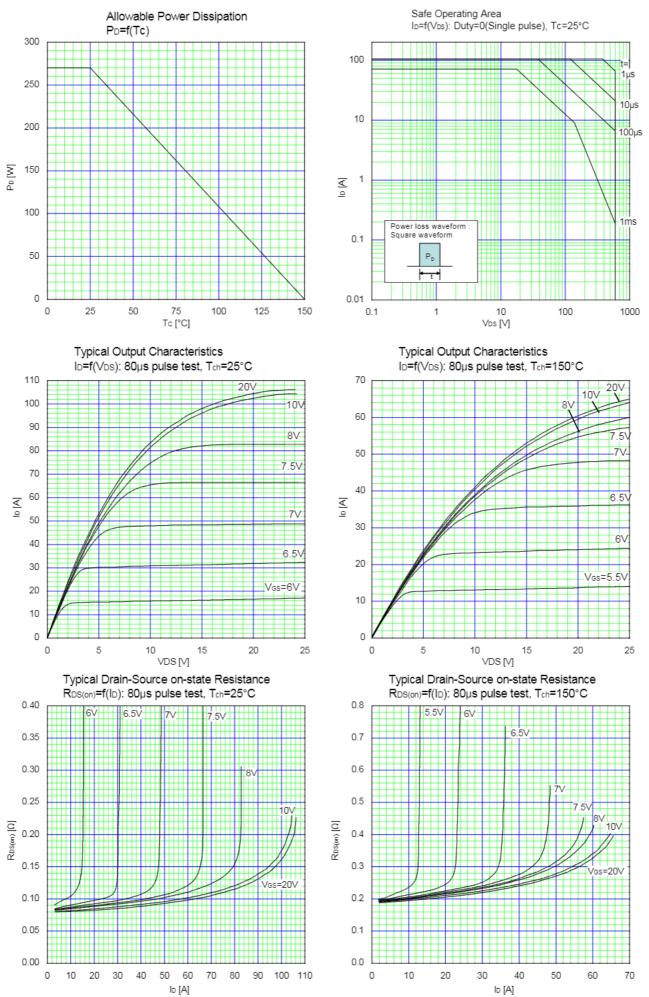
Note *6 : $C_{0(e)}$ is a fixed capacitance that gives the same stored energy as C_{068} while V_{D8} is rising from 0 to 80% BVoss. Note *7 : $C_{0(0)}$ is a fixed capacitance that gives the same charging times as C_{068} while V_{D8} is rising from 0 to 80% BVoss.

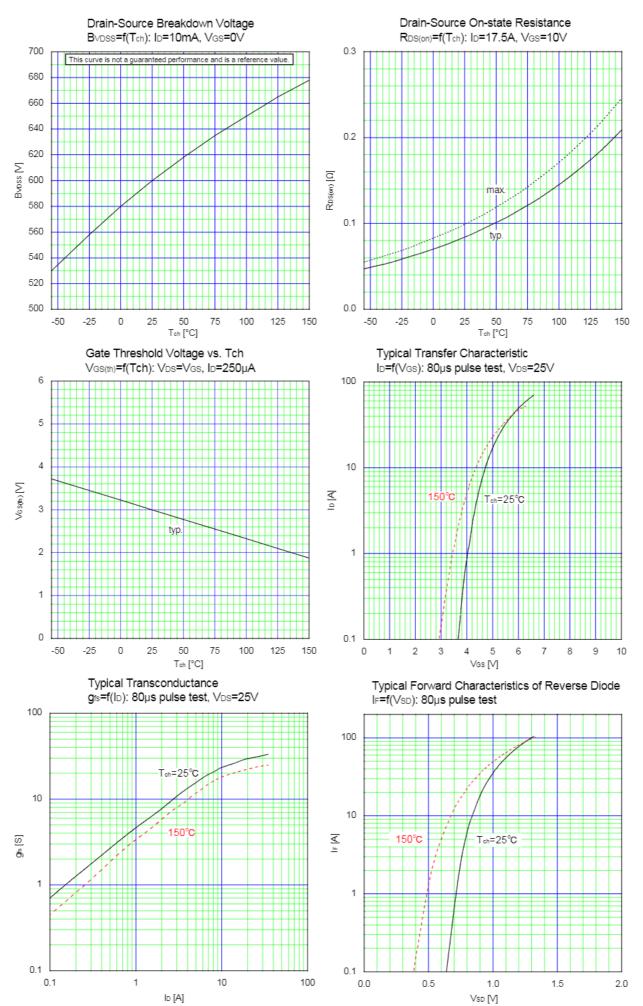
Reverse Diode

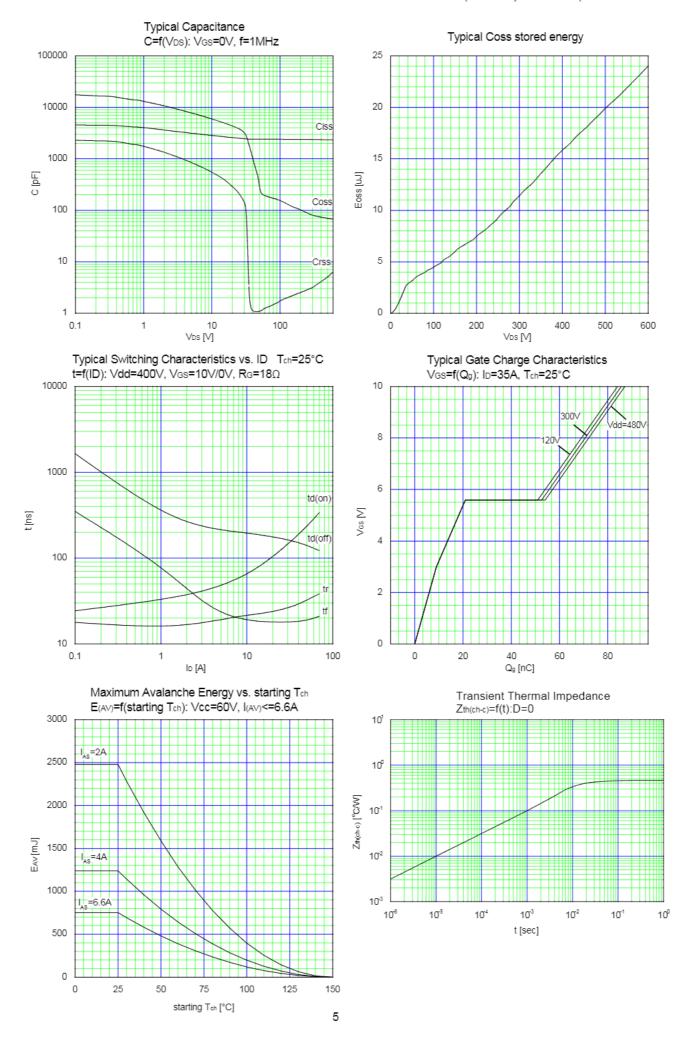
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
Avalanche Capability	lav	L=31.6mH, T _{oh} =25°C See Fig.1 and Fig.2	6.6	-	-	А
Diode Forward On-Voltage	Vso	I _F =35A, V _{GS} =0V T _{ch} =25°C	-	1	1.35	٧
Reverse Recovery Time	trr	I⊧=35A, V₀₀=400V -di/dt=100A/µs T₀n=25°C See Fig.6 and Fig.7		470	-	ns
Reverse Recovery Charge	Qrr		-	9.2	-	μC
Peak Reverse Recovery Current	Irp		-	39	-	А

■ Thermal Resistance

Parameter	Symbol	min.	typ.	max.	Unit
Channel to Case	R _{th(ch-c)}	-	-	0.46	°C/W
Channel to Ambient	R _{th(ch-a)}	-	-	50	°C/W







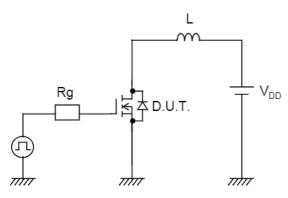


Fig.1 Avalanche Test circuit

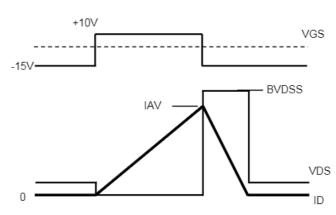


Fig.2 Operating waveforms of Avalanche Test

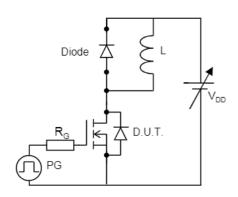


Fig.3 Switching Test circuit

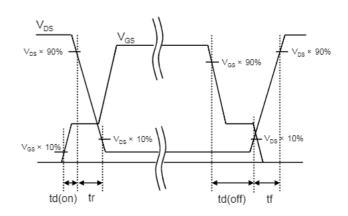


Fig.4 Operating waveform of Switching Test

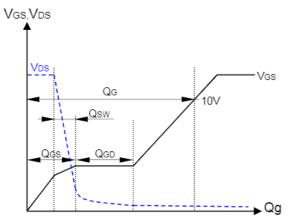


Fig.5 Operating waveform of Gate charge Test

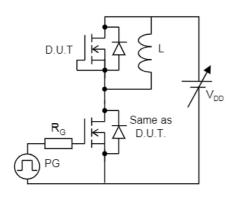


Fig.6 Reverse recovery Test circuit

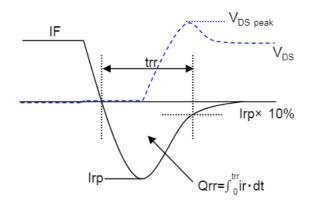
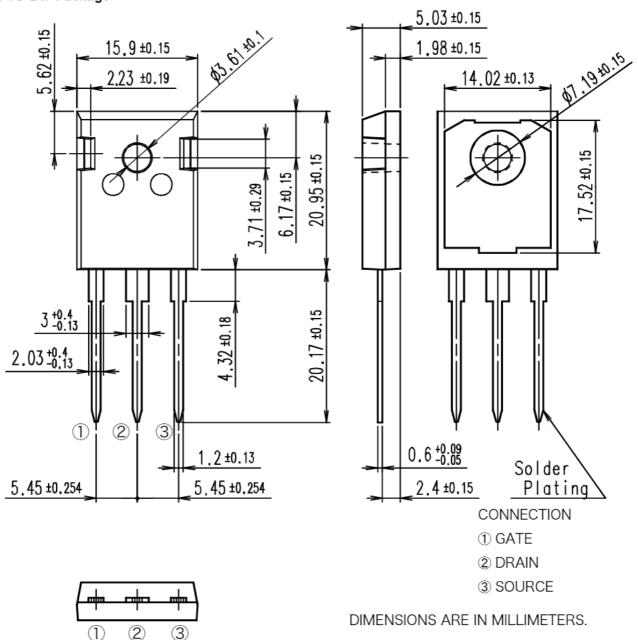
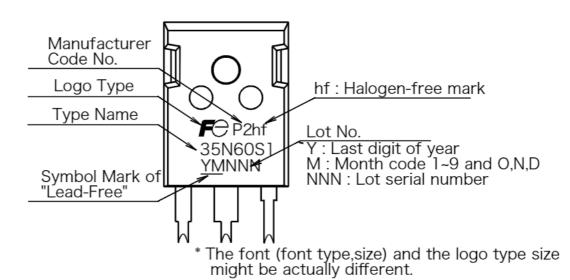


Fig.7 Operating waveform of Reverse recovery Test

Outview: TO-247 Package



Marking



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